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FDME1034CZT

Complementary PowerTrench® MOSFET

N-channel: 20 V, 3.8 A, 66 mΩ P-channel: -20 V, -2.6 A, 142 mΩ

Features

Q1: N-Channel

- Max $r_{DS(on)}$ = 66 mΩ at $V_{GS} = 4.5$ V, $I_D = 3.4$ A
- Max $r_{DS(on)}$ = 86 mΩ at $V_{GS} = 2.5$ V, $I_D = 2.9$ A
- Max $r_{DS(on)}$ = 113 mΩ at $V_{GS} = 1.8$ V, $I_D = 2.5$ A
- Max $r_{DS(on)}$ = 160 mΩ at $V_{GS} = 1.5$ V, $I_D = 2.1$ A

Q2: P-Channel

- Max $r_{DS(on)}$ = 142 mΩ at $V_{GS} = -4.5$ V, $I_D = -2.3$ A
- Max $r_{DS(on)}$ = 213 mΩ at $V_{GS} = -2.5$ V, $I_D = -1.8$ A
- Max $r_{DS(on)}$ = 331 mΩ at $V_{GS} = -1.8$ V, $I_D = -1.5$ A
- Max $r_{DS(on)}$ = 530 mΩ at $V_{GS} = -1.5$ V, $I_D = -1.2$ A

- Low profile: 0.55 mm maximum in the new package MicroFET 1.6x1.6 Thin

- Free from halogenated compounds and antimony oxides

- HBM ESD protection level > 1600 V (Note 3)

- RoHS Compliant



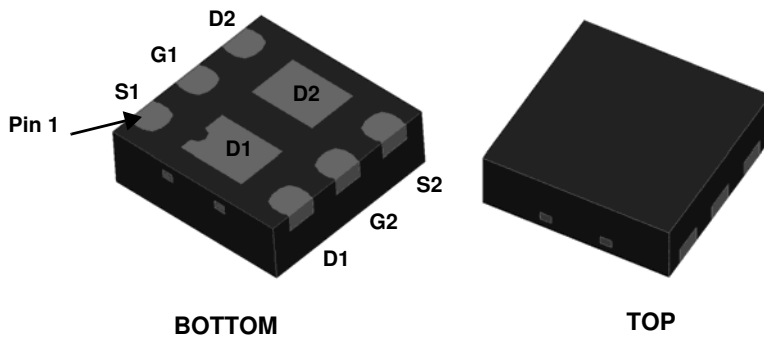
General Description

This device is designed specifically as a single package solution for a DC/DC 'Switching' MOSFET in cellular handset and other ultra-portable applications. It features an independent N-Channel & P-Channel MOSFET with low on-state resistance for minimum conduction losses. The gate charge of each MOSFET is also minimized to allow high frequency switching directly from the controlling device.

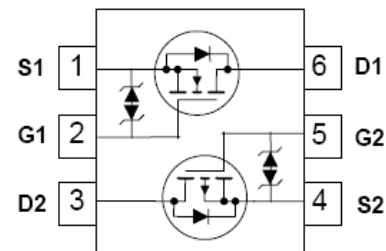
The MicroFET 1.6x1.6 Thin package offers exceptional thermal performance for its physical size and is well suited to switching and linear mode applications.

Applications

- DC-DC Conversion
- Level Shifted Load Switch



MicroFET 1.6x1.6 Thin



MOSFET Maximum Ratings $T_A = 25$ °C unless otherwise noted

| Symbol | Parameter | Q1 | Q2 | Units |
|----------------|--|-------------|------|-------|
| V_{DS} | Drain to Source Voltage | 20 | -20 | V |
| V_{GS} | Gate to Source Voltage | ±8 | ±8 | V |
| I_D | Drain Current -Continuous $T_A = 25$ °C (Note 1a) | 3.8 | -2.6 | A |
| | -Pulsed | 6 | -6 | |
| P_D | Power Dissipation for Single Operation $T_A = 25$ °C (Note 1a) | 1.4 | | W |
| | Power Dissipation for Single Operation $T_A = 25$ °C (Note 1b) | 0.6 | | |
| T_J, T_{STG} | Operating and Storage Junction Temperature Range | -55 to +150 | | °C |

Thermal Characteristics

| | | | |
|-----------------|--|-----|------|
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient (Single Operation) (Note 1a) | 90 | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient (Single Operation) (Note 1b) | 195 | |

Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|----------------|-------------|-----------------------|-----------|------------|------------|
| 5T | FDME1034CZT | MicroFET 1.6x1.6 Thin | 7" | 8 mm | 5000 units |

Electrical Characteristics $T_J = 25\text{ }^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Type | Min | Typ | Max | Units |
|--------|-----------|-----------------|------|-----|-----|-----|-------|
|--------|-----------|-----------------|------|-----|-----|-----|-------|

Off Characteristics

| | | | | | | | |
|--------------------------------------|---|---|----------|-----------|-----------|----------|----------------------|
| BV_{DSS} | Drain to Source Breakdown Voltage | $I_D = 250\text{ }\mu\text{A}$, $V_{GS} = 0\text{ V}$ $I_D = -250\text{ }\mu\text{A}$, $V_{GS} = 0\text{ V}$ | Q1 Q2 | 20 -20 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $I_D = 250\text{ }\mu\text{A}$, referenced to $25\text{ }^\circ\text{C}$ $I_D = -250\text{ }\mu\text{A}$, referenced to $25\text{ }^\circ\text{C}$ | Q1 Q2 | | 16 -12 | | mV/ $^\circ\text{C}$ |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 16\text{ V}$, $V_{GS} = 0\text{ V}$ $V_{DS} = -16\text{ V}$, $V_{GS} = 0\text{ V}$ | Q1 Q2 | | | 1 -1 | μA |
| I_{GSS} | Gate to Source Leakage Current | $V_{GS} = \pm 8\text{ V}$, $V_{DS} = 0\text{ V}$ | All | | | ± 10 | μA |

On Characteristics

| | | | | | | | |
|--|--|---|----------|-------------|-------------|-------------|----------------------|
| $V_{GS(th)}$ | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}$, $I_D = 250\text{ }\mu\text{A}$ $V_{GS} = V_{DS}$, $I_D = -250\text{ }\mu\text{A}$ | Q1 Q2 | 0.4 -0.4 | 0.7 -0.6 | 1.0 -1.0 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | $I_D = 250\text{ }\mu\text{A}$, referenced to $25\text{ }^\circ\text{C}$ | Q1 Q2 | | -3 2 | | mV/ $^\circ\text{C}$ |
| $r_{DS(on)}$ | Drain to Source On Resistance | $V_{GS} = 4.5\text{ V}$, $I_D = 3.4\text{ A}$ | Q1 | | 55 | 66 | m Ω |
| | | $V_{GS} = 2.5\text{ V}$, $I_D = 2.9\text{ A}$ | | 68 | 86 | | |
| | | $V_{GS} = 1.8\text{ V}$, $I_D = 2.5\text{ A}$ | | 85 | 113 | | |
| | | $V_{GS} = 1.5\text{ V}$, $I_D = 2.1\text{ A}$ | | 106 | 160 | | |
| | | $V_{GS} = 4.5\text{ V}$, $I_D = 3.4\text{ A}$, $T_J = 125\text{ }^\circ\text{C}$ | | 76 | 112 | | |
| | | $V_{GS} = -4.5\text{ V}$, $I_D = -2.3\text{ A}$ | Q2 | | 95 | 142 | |
| | | $V_{GS} = -2.5\text{ V}$, $I_D = -1.8\text{ A}$ | | 120 | 213 | | |
| | | $V_{GS} = -1.8\text{ V}$, $I_D = -1.5\text{ A}$ | | 150 | 331 | | |
| | | $V_{GS} = -1.5\text{ V}$, $I_D = -1.2\text{ A}$ | | 190 | 530 | | |
| | | $V_{GS} = -4.5\text{ V}$, $I_D = -2.3\text{ A}$, $T_J = 125\text{ }^\circ\text{C}$ | | 128 | 190 | | |
| g_{FS} | Forward Transconductance | $V_{DS} = 4.5\text{ V}$, $I_D = 3.4\text{ A}$ $V_{DS} = -4.5\text{ V}$, $I_D = -2.3\text{ A}$ | Q1 Q2 | | 9 7 | | S |

Dynamic Characteristics

| | | | | | | | |
|-----------|------------------------------|--|----------|------------|------------|--|----|
| C_{iss} | Input Capacitance | Q1 Q2 | | 225 305 | 300 405 | | pF |
| C_{oss} | Output Capacitance | $V_{DS} = 10\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 1\text{ MHz}$ Q1 Q2 | Q1 Q2 | 40 55 | 55 75 | | pF |
| C_{rss} | Reverse Transfer Capacitance | $V_{DS} = -10\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 1\text{ MHz}$ Q1 Q2 | Q1 Q2 | 25 50 | 40 75 | | pF |

Switching Characteristics

| | | | | | | | | |
|--------------|-------------------------------|---|----------|------------|------------|--|----|----|
| $t_{d(on)}$ | Turn-On Delay Time | Q1 Q2 | | 4.5 4.7 | 10 10 | | ns | |
| t_r | Rise Time | $V_{DD} = 10\text{ V}$, $I_D = 1\text{ A}$, $V_{GS} = 4.5\text{ V}$, $R_{GEN} = 6\text{ }\Omega$ Q1 Q2 | Q1 Q2 | 2.0 4.8 | 10 10 | | | |
| $t_{d(off)}$ | Turn-Off Delay Time | $V_{DD} = -10\text{ V}$, $I_D = -1\text{ A}$, $V_{GS} = -4.5\text{ V}$, $R_{GEN} = 6\text{ }\Omega$ Q1 Q2 | Q1 Q2 | 15 33 | 27 53 | | | |
| t_f | Fall Time | Q1 Q2 | | 1.7 16 | 10 29 | | | |
| Q_g | Total Gate Charge | Q1 $V_{DD} = 10\text{ V}$, $I_D = 3.4\text{ A}$, Q2 | Q1 Q2 | 3 5.5 | 4.2 7.7 | | | nC |
| Q_{gs} | Gate to Source Gate Charge | $V_{GS} = 4.5\text{ V}$ Q1 Q2 | Q1 Q2 | 0.4 0.6 | | | | |
| Q_{gd} | Gate to Drain "Miller" Charge | $V_{DD} = -10\text{ V}$, $I_D = -2.3\text{ A}$, $V_{GS} = -4.5\text{ V}$ Q1 Q2 | Q1 Q2 | 0.6 1.4 | | | | |

Electrical Characteristics $T_J = 25\text{ }^\circ\text{C}$ unless otherwise noted

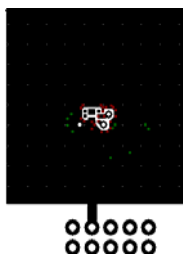
| Symbol | Parameter | Test Conditions | Type | Min | Typ | Max | Units |
|--------|-----------|-----------------|------|-----|-----|-----|-------|
|--------|-----------|-----------------|------|-----|-----|-----|-------|

Drain-Source Diode Characteristics

| | | | | | | | |
|----------|---------------------------------------|---|----|--|------|------|----|
| V_{SD} | Source to Drain Diode Forward Voltage | $V_{GS} = 0\text{ V}, I_S = 0.9\text{ A}$ (Note 2) | Q1 | | 0.7 | 1.2 | V |
| | | $V_{GS} = 0\text{ V}, I_S = -0.9\text{ A}$ (Note 2) | Q2 | | -0.8 | -1.2 | |
| t_{rr} | Reverse Recovery Time | Q1 $I_F = 3.4\text{ A}, di/dt = 100\text{ A}/\mu\text{S}$ | Q1 | | 8.5 | 17 | ns |
| | | | Q2 | | 16 | 29 | |
| Q_{rr} | Reverse Recovery Time | Q2 $I_F = -2.3\text{ A}, di/dt = 100\text{ A}/\mu\text{S}$ | Q1 | | 1.4 | 10 | nC |
| | | | Q2 | | 4.4 | 10 | |

Notes:

- $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a. 90 °C/W when mounted on a 1 in² pad of 2 oz copper.



b. 195 °C/W when mounted on a minimum pad of 2 oz copper.

- Pulse Test: Pulse Width < 300 μs , Duty cycle < 2.0%.

- The diode connected between the gate and source serves only as protection ESD. No gate overvoltage rating is implied.

Typical Characteristics (Q1 N-Channel) $T_J = 25^\circ\text{C}$ unless otherwise noted

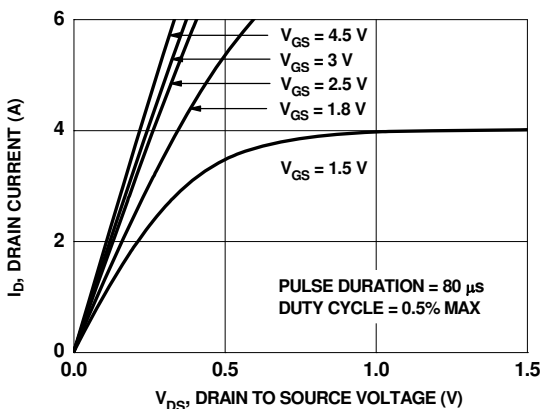


Figure 1. On Region Characteristics

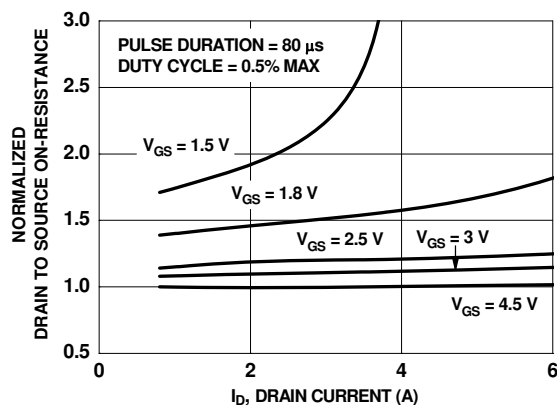


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

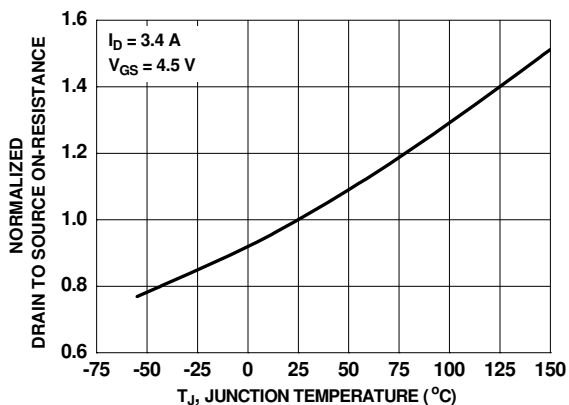


Figure 3. Normalized On Resistance vs Junction Temperature

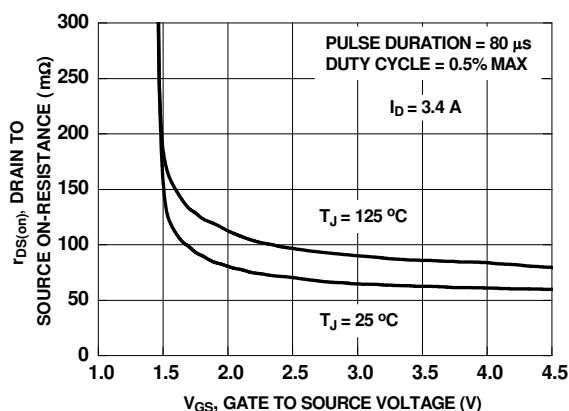


Figure 4. On-Resistance vs Gate to Source Voltage

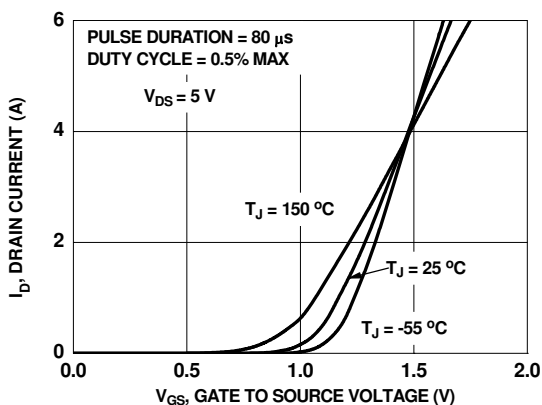


Figure 5. Transfer Characteristics

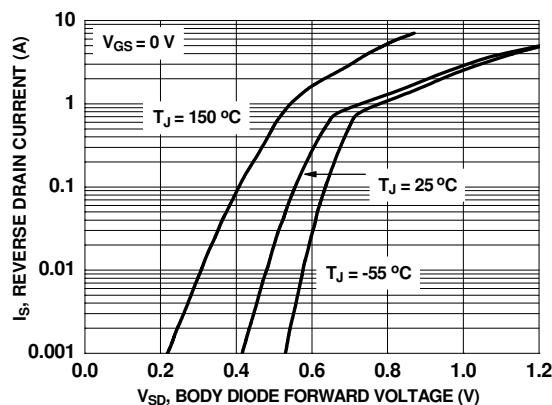


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics (Q1 N-Channel) $T_J = 25^\circ\text{C}$ unless otherwise noted

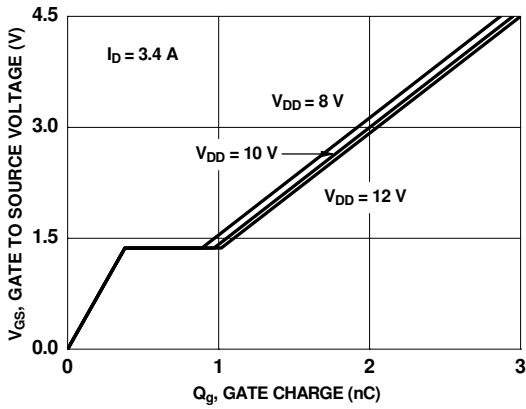


Figure 7. Gate Charge Characteristics

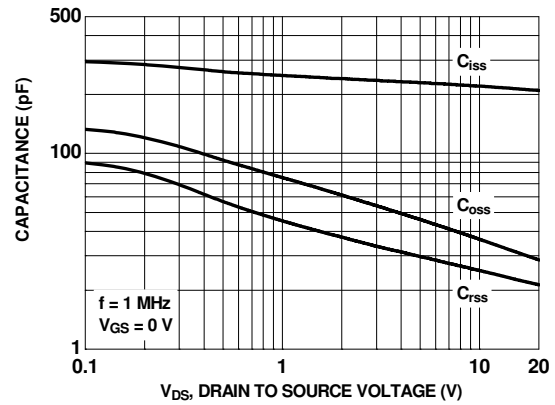


Figure 8. Capacitance vs Drain to Source Voltage

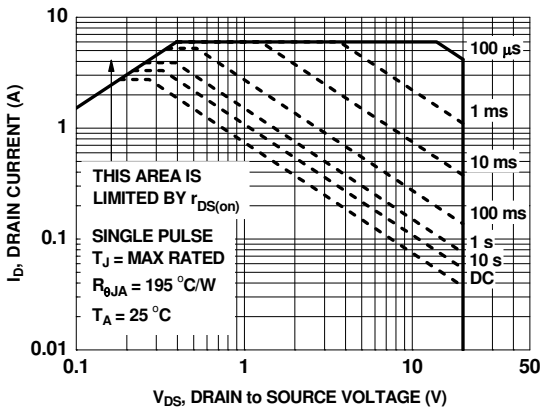


Figure 9. Forward Bias Safe Operating Area

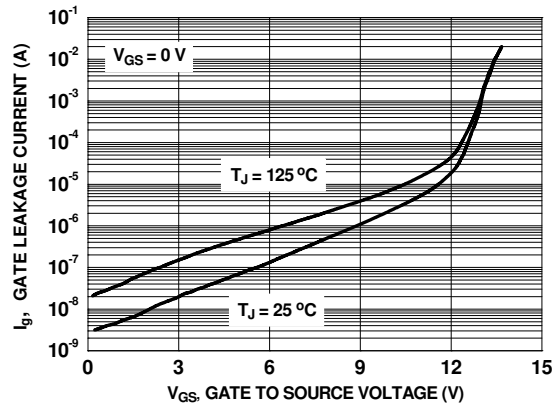


Figure 10. Gate Leakage Current vs Gate to Source Voltage

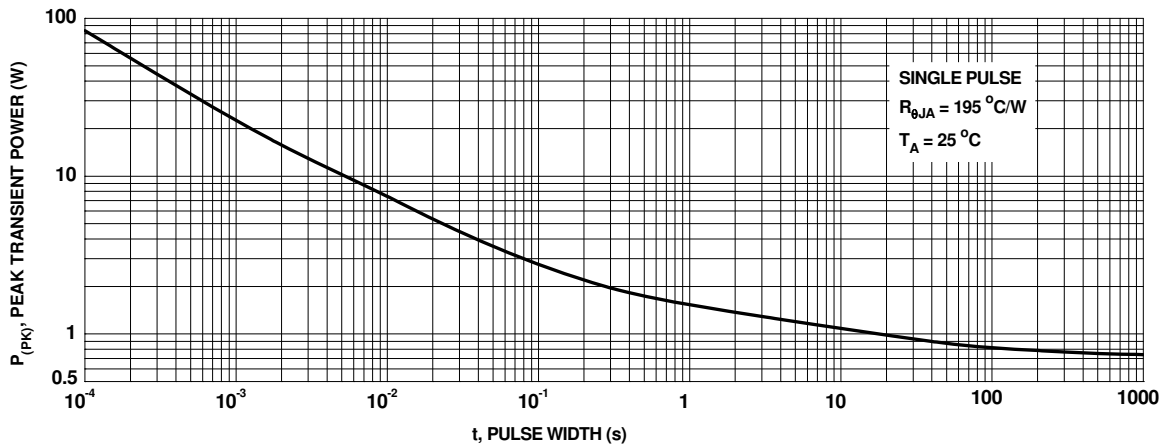


Figure 11. Single Pulse Maximum Power Dissipation

Typical Characteristics (Q1 N-Channel) $T_J = 25^\circ\text{C}$ unless otherwise noted

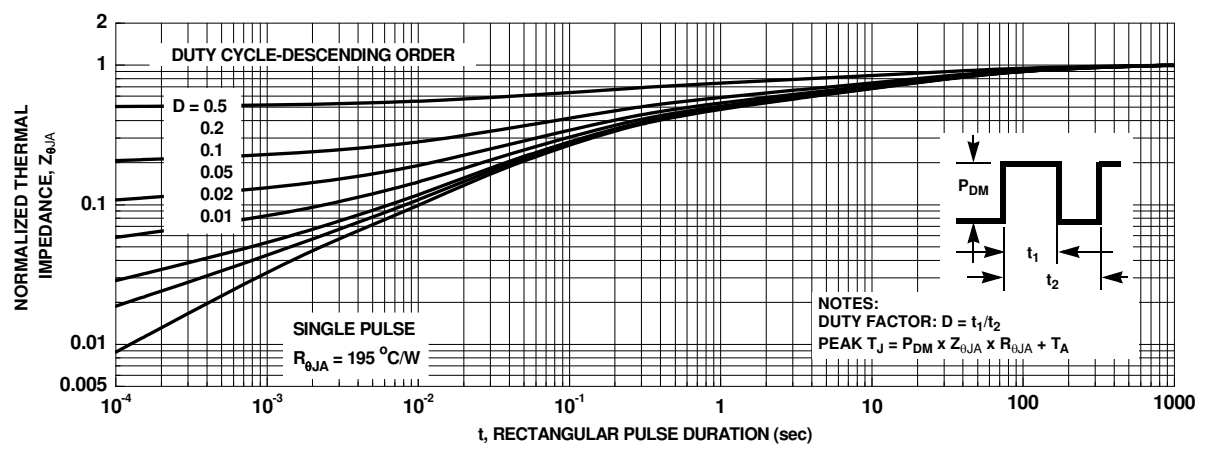


Figure 12. Junction-to-Ambient Transient Thermal Response Curve

Typical Characteristics (Q2 P-Channel) $T_J = 25\text{ }^\circ\text{C}$ unless otherwise noted

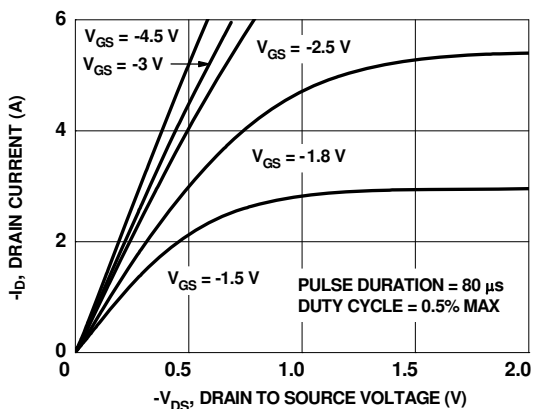


Figure 13. On-Region Characteristics

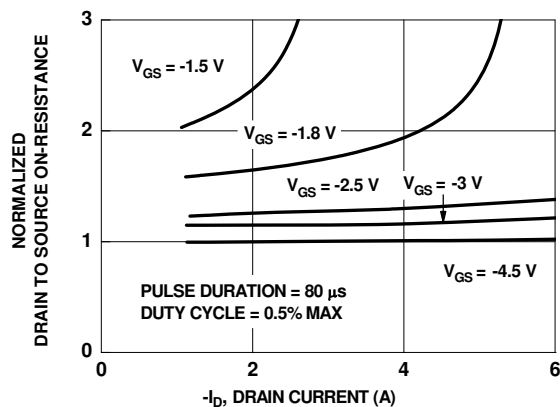


Figure 14. Normalized on-Resistance vs Drain Current and Gate Voltage

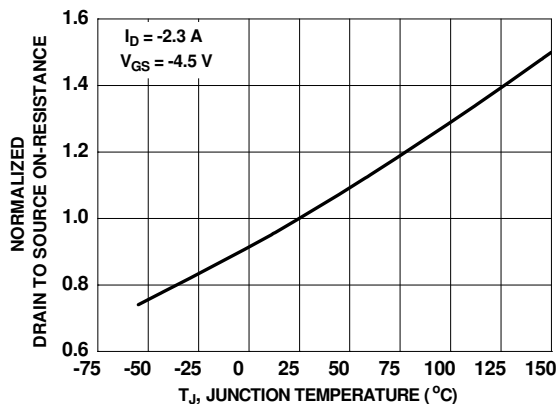


Figure 15. Normalized On-Resistance vs Junction Temperature

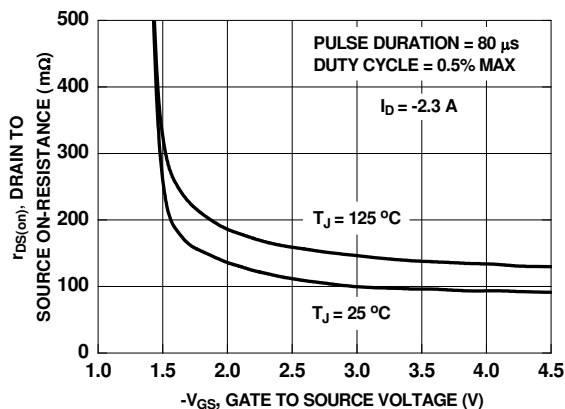


Figure 16. On-Resistance vs Gate to Source Voltage

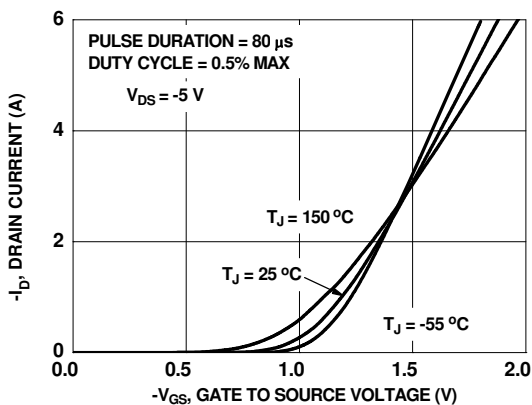


Figure 17. Transfer Characteristics

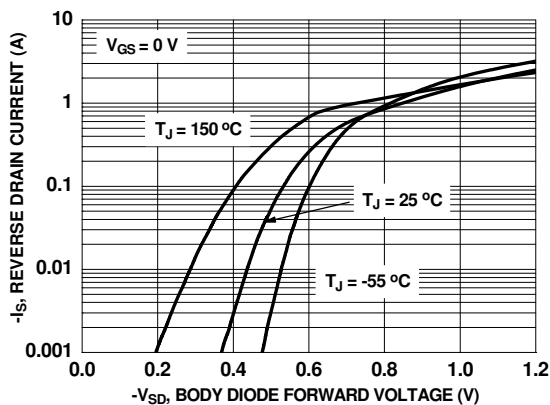


Figure 18. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics (Q2 P-Channel) $T_J = 25^\circ\text{C}$ unless otherwise noted

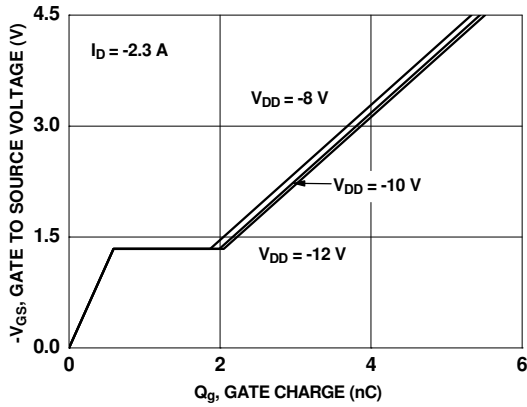


Figure 19. Gate Charge Characteristics

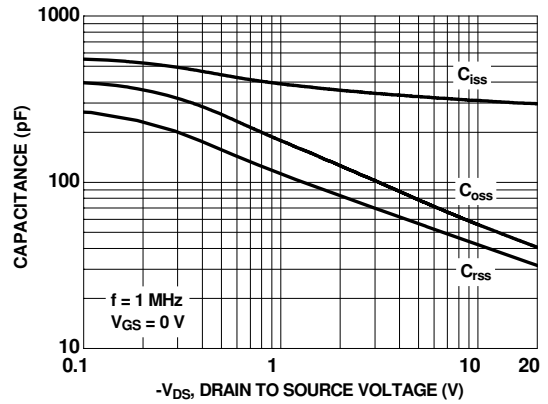


Figure 20. Capacitance vs Drain to Source Voltage

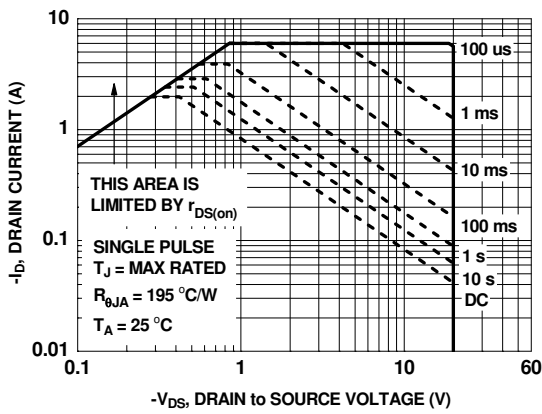


Figure 21. Forward Bias Safe Operating Area

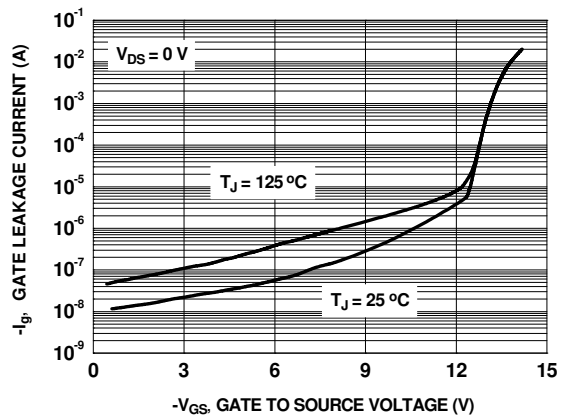


Figure 22. Gate Leakage Current vs Gate to Source Voltage

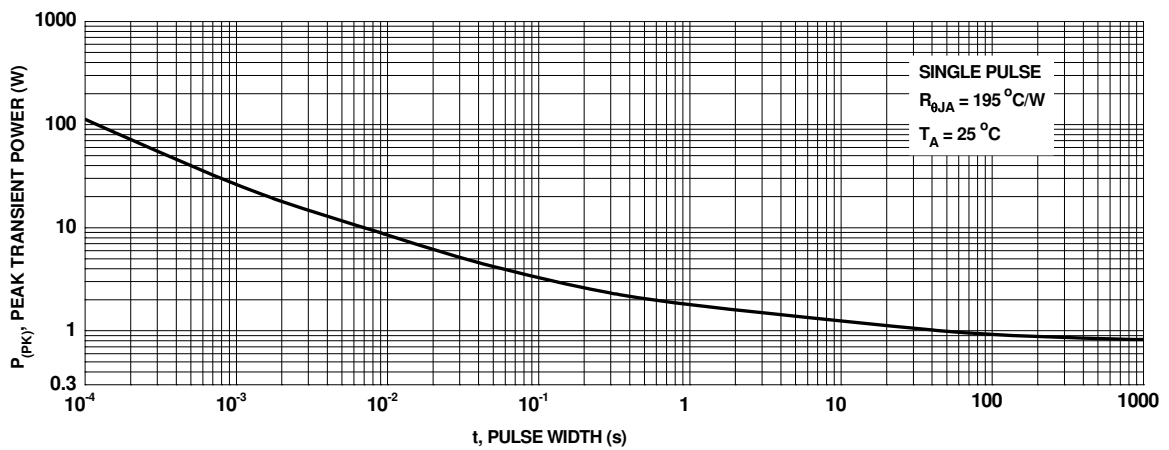


Fig 23. Single Pulse Maximum Power Dissipation

Typical Characteristics (Q2 P-Channel) $T_J = 25\text{ }^\circ\text{C}$ unless otherwise noted

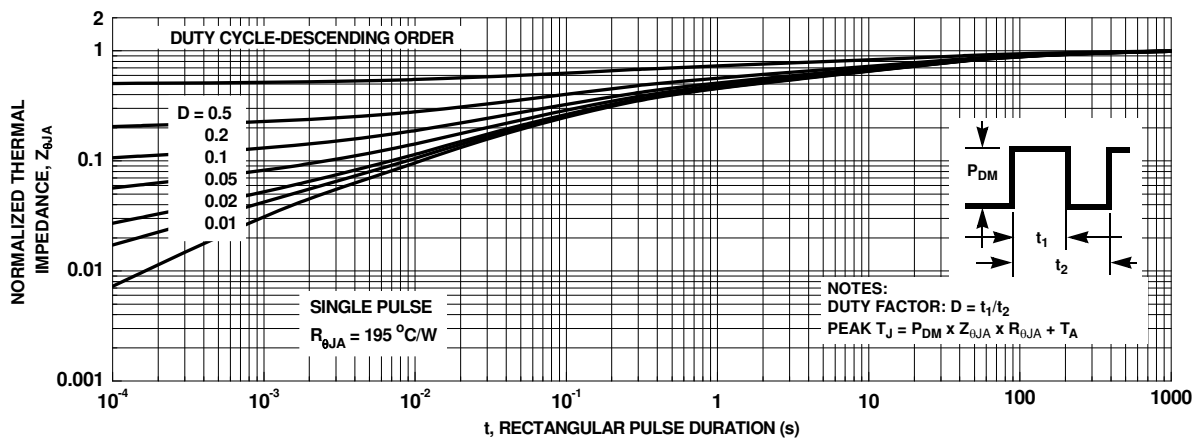
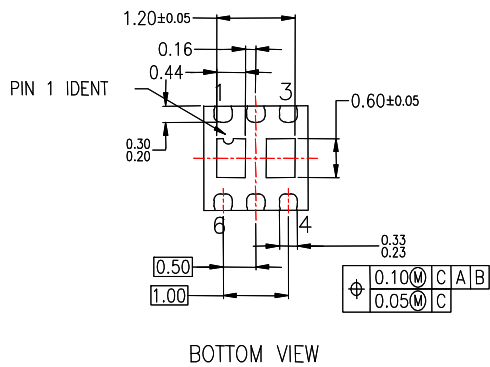
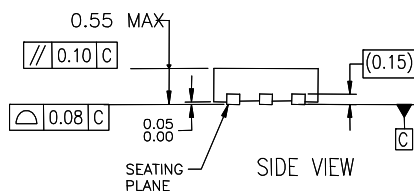
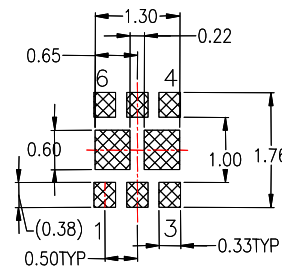
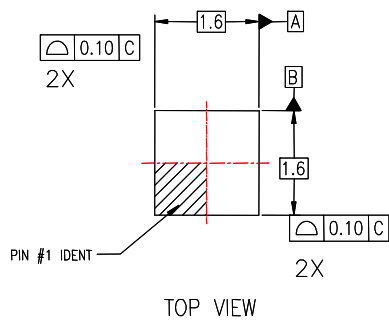


Figure 24. Junction-to-Ambient Transient Thermal Response Curve

Dimensional Outline and Pad Layout





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